

N-Channel Enhancement Mode

$$V_{DS} = 1200\text{ V}$$

$$R_{DS(on)} = 25\text{ m}\Omega$$

$$I_{DS@25^{\circ}\text{C}} = 90\text{ A}$$

Features

- High Blocking Voltage with low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness

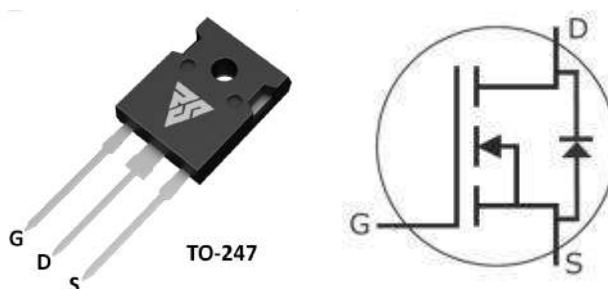
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- Motor Drivers
- Pulsed Power Applications

Chip Outline



Part Number	Package
RSM120025W	TO-247-3

Maximum Ratings ($T_c=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain-Source Voltage	1200	V	$V_{GS}=0\text{V}$, $I_{DS}=100\mu\text{A}$	
V_{GSmax}	Gate-Source Voltage	-10/+25	V	Absolute maximum values	
V_{GSop}	Gate-Source Voltage	-5/+20	V	Recommended operational values	
I_D	Continuous Drain Current	90	A	$V_{GS}=20\text{V}$, $T_c=25^{\circ}\text{C}$	
		60	A	$V_{GS}=20\text{V}$, $T_c=100^{\circ}\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	250	A	Pulse width t_p limited by T_{jmax}	
P_D	Power Dissipation	463	W	$T_c=25^{\circ}\text{C}$, $T_J=150^{\circ}\text{C}$	
T_J, T_{STG}	Operating Junction and Storage Temperature	-40 to +150	$^{\circ}\text{C}$		
T_L	Solder Temperature	260	$^{\circ}\text{C}$	1.6mm(0.063") from case for 10s	

Electrical Characteristics($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200	/	/	V	$V_{GS}=0V, I_{DS}=100\mu A$	
$V_{GS(th)}$	Gate Threshold Voltage	2.0	2.4	4	V	$V_{DS}=V_{GS}, I_{DS}=15mA$	
			1.8	/		$V_{DS}=V_{GS}, I_{DS}=15mA, T_J=150^{\circ}\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current	/	1	100	μA	$V_{DS}=1200V, V_{GS}=0V$	
I_{GSS}	Gate-Source Leakage Current	/		250	nA	$V_{DS}=0V, V_{GS}=20V$	
$R_{DS(on)}$	Drain-Source On-State Resistance	/	25	34	$m\Omega$	$V_{GS}=20V, I_D=50A$	
		/	43			$V_{GS}=20V, I_D=50A, T_J=150^{\circ}\text{C}$	
g_{fs}	Transconductance	/	22.8	/	S	$V_{DS}=20V, I_D=50A$	
		/	21.2	/		$V_{DS}=20V, I_D=50A, T_J=150^{\circ}\text{C}$	
C_{iss}	Input Capacitance	/	3600	/	pF	$V_{GS}=0V$	
C_{oss}	Output Capacitance	/	240	/		$V_{DS}=1000V$	
C_{rss}	Reverse Transfer Capacitance	/	16	/		$f=1MHz$	
E_{oss}	C_{oss} Stored Energy	/	122	/		$V_{AC}=25mV$	
t_{don}	Turn-On Delay Time	/	16	/	ns	$V_{DS}=800V, V_{GS}=-5V/20V$	
t_r	Rise Time	/	16.2	/		$I_D=30A, R_g=2.5\Omega$	
t_{doff}	Turn-Off Delay Time	/	33	/		$R_l=2.5\Omega$	
t_f	Fall Time	/	7.8	/		(TO-247-3Package)	
E_{ON}	Turn-On Switching Energy	/	1.8	/	μJ	$V_{DS}=800V, V_{GS}=-5V/20V$	
E_{OFF}	Turn-Off Switching Energy	/	1.5	/		$I_D=30A, R_g=2.5\Omega, L=200\mu H$ (TO-247-3Package)	
R_g	Internal Gate Resistance	/	2.0	/	Ω	$f=1MHz$ open drain	
Q_{gs}	Gate Charge Total	/	54	/	nC	$V_{DS}=800V$	
Q_{gd}	Gate to Source Charge	/	29	/		$V_{GS}=-5V/20V$	
Q_g	Gate to Drain Charge	/	195	/		$I_D=30A$	

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	3.6		V	$V_{GS}=-5V, I_F=25A$	
		3.3			$V_{GS}=-5V, I_F=25A, T_J=150^{\circ}\text{C}$	
I_s	Continuous Diode Forward Current		90	A	$T_C=25^{\circ}\text{C}$	
t_{rr}	Reverse Recover time	55		ns	$V_{GS}=-5V, I_{SD}=25A, V_R=800V$	
Q_{rr}	Reverse Recovery Charge	320		nC		
I_{rrm}	Peak Reverse Recovery Current	10.7		A		

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance	0.24	0.28	$^{\circ}\text{C}/\text{W}$		

Typical Performance

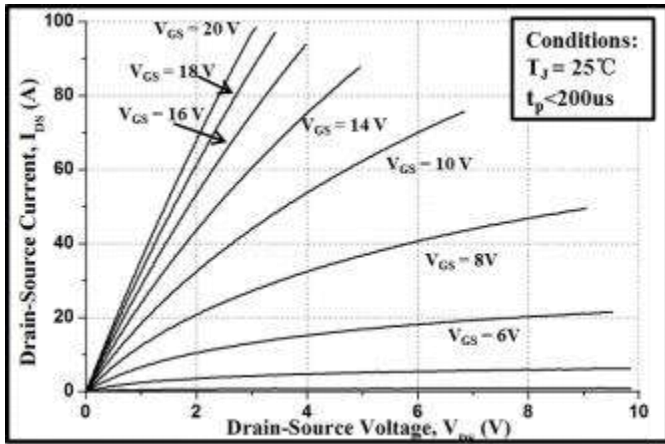


Figure 1. Typical Output Characteristics $T_J=25^\circ\text{C}$

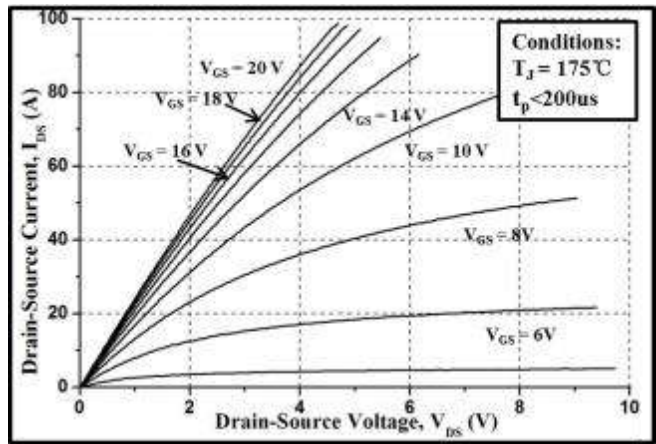


Figure 2. Typical Output Characteristics $T_J=175^\circ\text{C}$

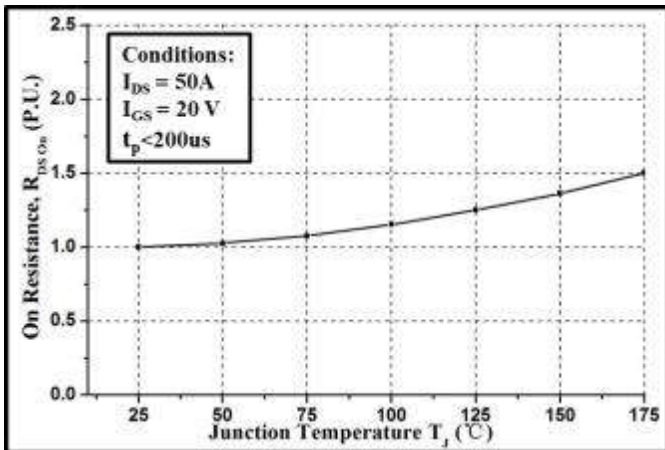


Figure 3. Normalized On-Resistance vs. Temperature

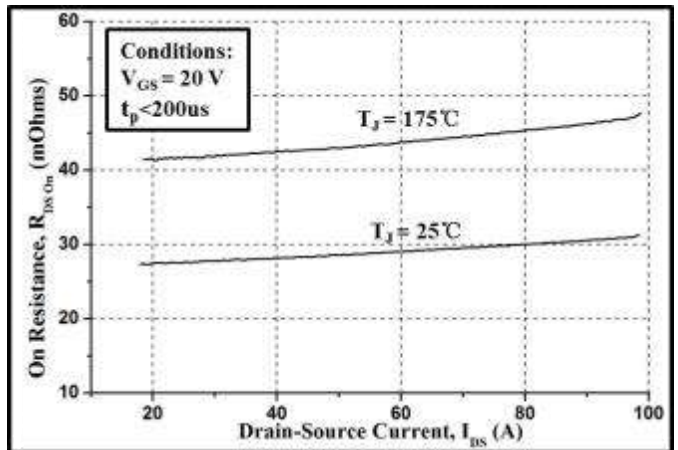


Figure 4. On-Resistance vs. Drain Current

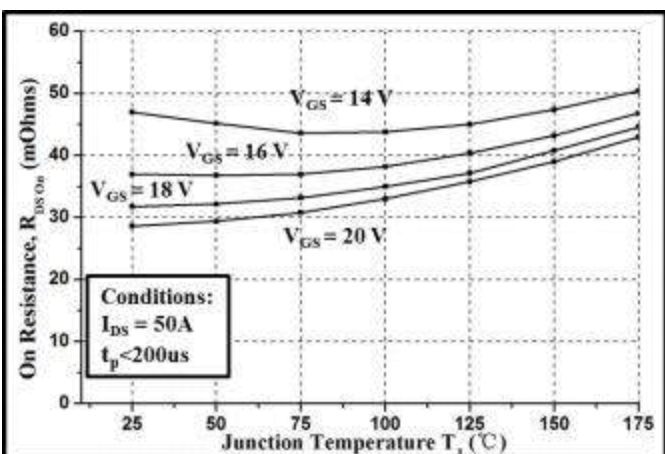


Figure 5. On-Resistance vs. Temperature

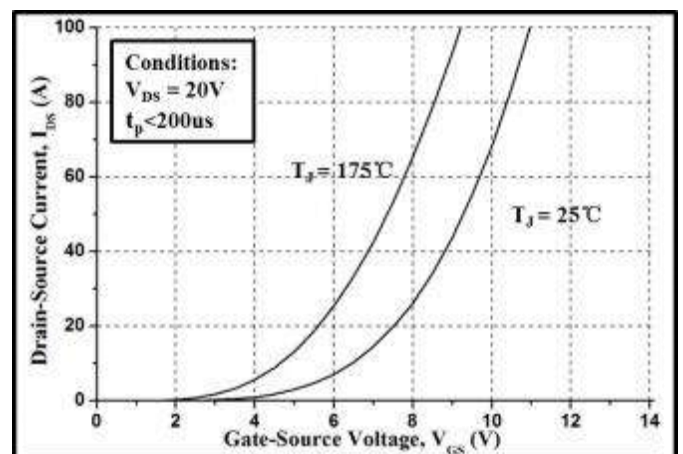


Figure 6. Typical Transfer Characteristics

Typical Performance

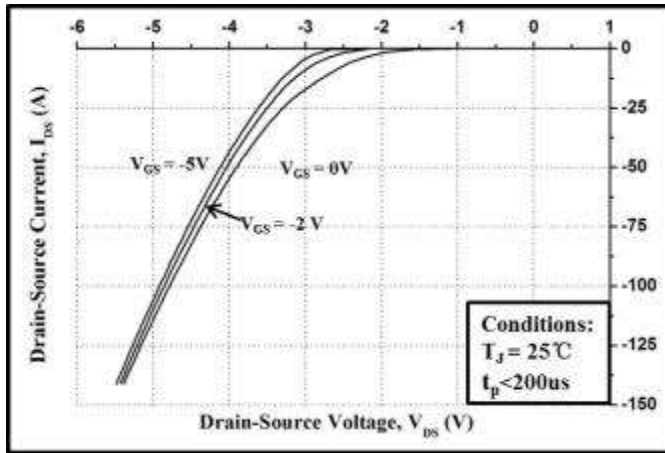


Figure 7. Body Diode Characteristics at 25°C

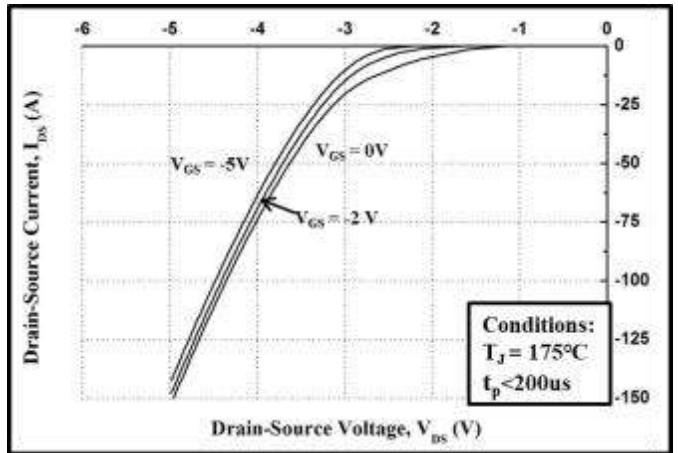


Figure 8. Body Diode Characteristics at 175°C

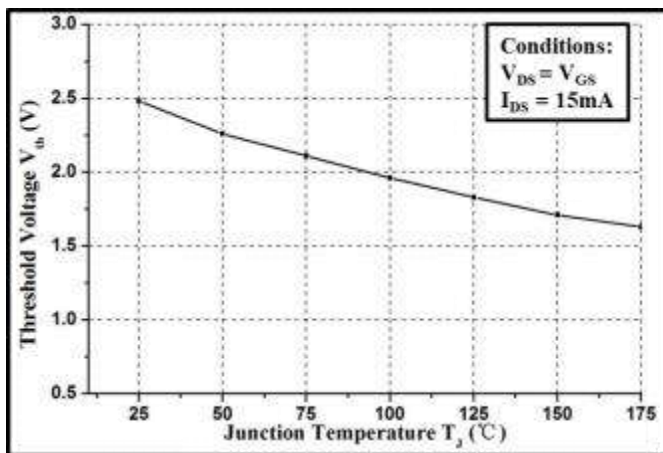


Figure 9. Gate Threshold Voltage vs. Temperature

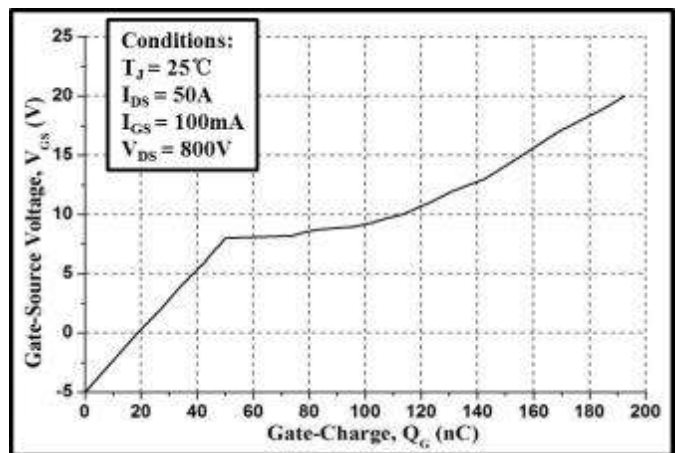


Figure 10. Gate Charge Characteristic

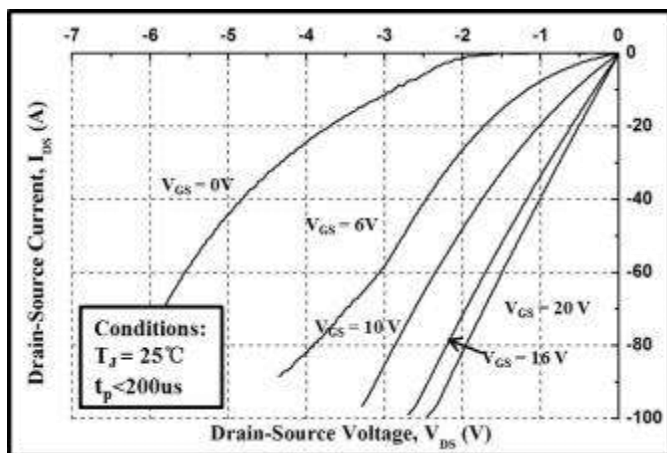


Figure 11. 3rd Quadrant Characteristics at 25° C

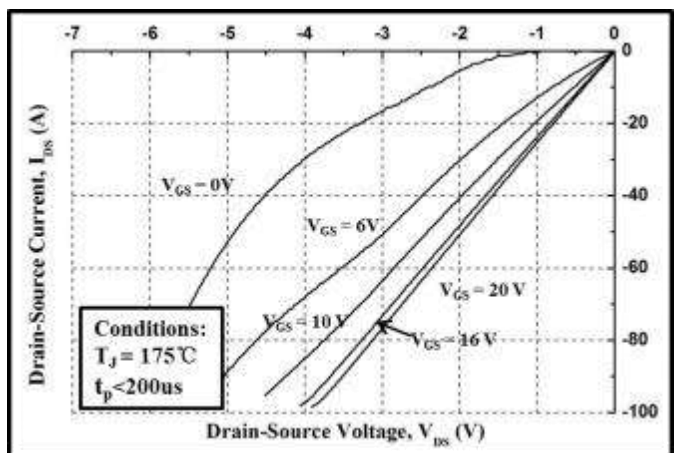


Figure 12. 3rd Quadrant Characteristics at 175° C

Typical Performance

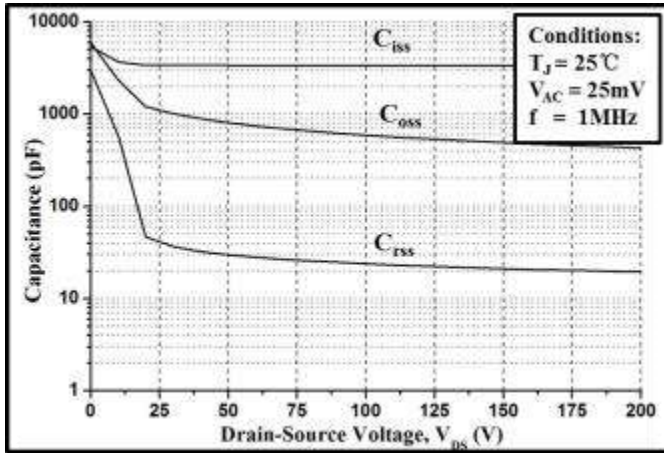


Figure 13. Capacitances vs. Drain-Source Voltage

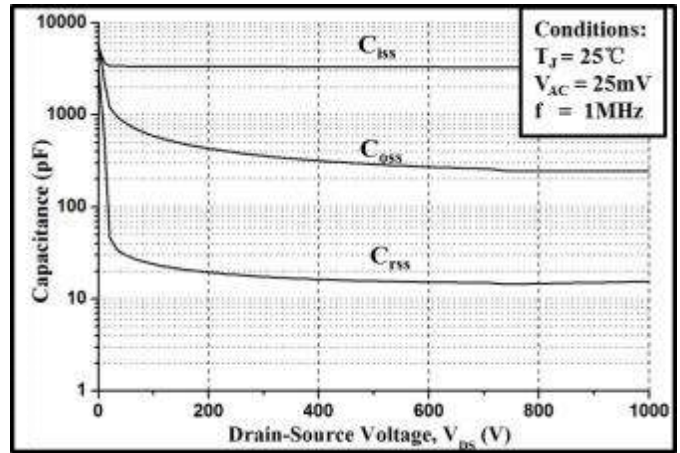


Figure 14. Capacitances vs. Drain-Source Voltage

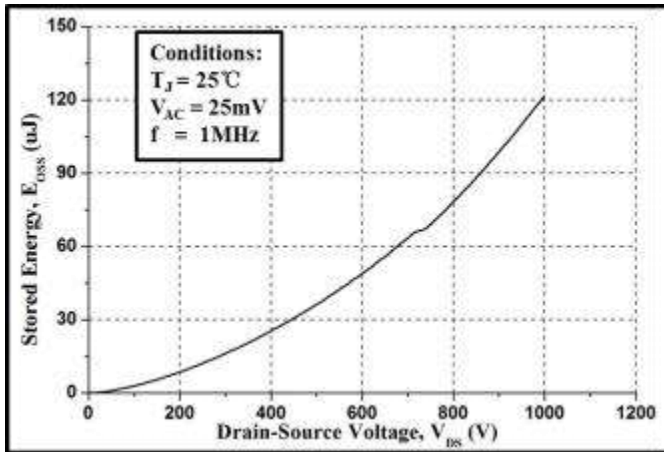
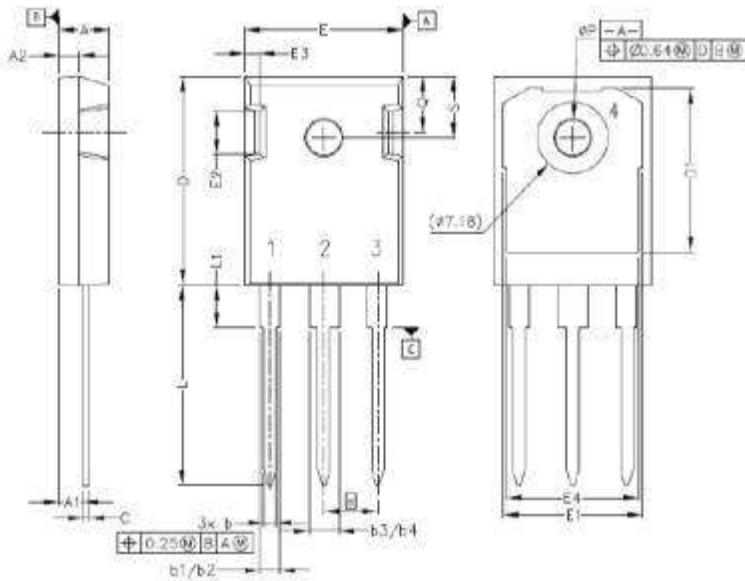


Figure 15. Output Capacitor Stored Energy

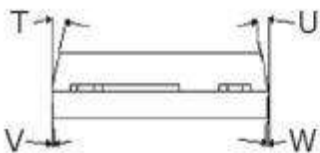
REASUNOS

RSM120025W

Package Dimension



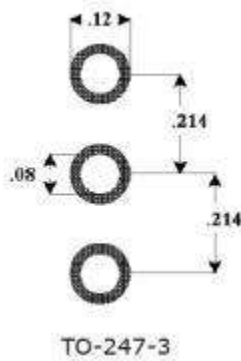
POS	Inches		Millimeters	
	Min	Max	Min	Max
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.042	.052	1.07	1.33
b1	.075	.095	1.91	2.41
b2	.075	.085	1.91	2.16
b3	.113	.133	2.87	3.38
b4	.113	.123	2.87	3.13
c	.022	.027	0.55	0.68
D	.819	.831	20.80	21.10
D1	.640	.695	16.25	17.65
D2	.037	.049	0.95	1.25
E	.620	.635	15.75	16.13
E1	.516	.557	13.10	14.15
E2	.145	.201	3.68	5.10
E3	.039	.075	1.00	1.90
E4	.487	.529	12.38	13.43
e	.214 BSC		5.44 BSC	
N	3		3	
L	.780	.800	19.81	20.32
L1	.161	.173	4.10	4.40
ØP	.138	.144	3.51	3.65
Q	.216	.236	5.49	6.00
S	.238	.248	6.04	6.30
T	9°	11°	9°	11°
U	9°	11°	9°	11°
V	2°	8°	2°	8°
W	2°	8°	2°	8°



Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

Recommended Solder Pad Layout



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